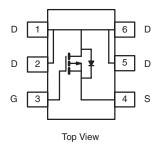


SCH1306-TL-E-VB Datasheet

P-Channel 30-V (D-S) MOSFET

| PRODUCT SUMMARY | | | | | |
|---------------------|------------------------------------|---------------------------------|-----------------------|--|--|
| V _{DS} (V) | R _{DS(on)} (Ω) | I _D (A) ^a | Q _g (Typ.) | | |
| - 30 | 0.032 at V _{GS} = - 10 V | -2.4 | 5.1 nC | | |
| | 0.042 at V _{GS} = - 4.5 V | - 2.0 | 5.1110 | | |

SC-75A (6-LEADS)



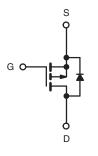
FEATURES

- Halogen-free According to IEC 61249-2-21 Available
- Trench Power MOSFET

APPLICATIONS

· Load Switch





P-Channel MOSFET

| Parameter | | Symbol | Limit | Unit | |
|--|------------------------|-----------------------------------|------------------------|------|--|
| Drain-Source Voltage | | V _{DS} | - 30 | V | |
| Gate-Source Voltage | | V _{GS} | ± 20 | | |
| Continuous Drain Current (T _J = 150 °C) | T _C = 25 °C | | - 2.4 | | |
| | T _C = 70 °C | | - 2.1 | | |
| | T _A = 25 °C | I _D | - 2.1 ^{b, c} | | |
| | T _A = 70 °C | | - 1.8 ^{b, c} | A | |
| Pulsed Drain Current | | I _{DM} | - 20 | | |
| Continuous Source-Drain Diode Current | T _C = 25 °C | | - 2.5 | | |
| | T _A = 25 °C | Is | - 1.67 ^{b, c} | | |
| Maximum Power Dissipation | T _C = 25 °C | | 2.0 | | |
| | T _C = 70 °C | | 1.0 | w | |
| | T _A = 25 °C | P _D | 1.3 ^{b, c} | VV | |
| | T _A = 70 °C | 1 | 0.8 ^{b, c} | | |
| Operating Junction and Storage Temperature Range | | T _J , T _{stq} | - 55 to 150 | °C | |

| THERMAL RESISTANCE RATINGS | | | | | | |
|---|--------------|-------------------|---------|---------|------|--|
| Parameter | | Symbol | Typical | Maximum | Unit | |
| Maximum Junction-to-Ambient ^{b, d} | t ≤ 5 s | R _{thJA} | 55 | 62.5 | °C/W | |
| Maximum Junction-to-Foot (Drain) | Steady State | R _{thJF} | 34 | 41 | C/VV | |

Notes:

a. Based on $T_C = 25 \text{ °C}$. b. Surface Mounted on 1" x 1" FR4 board.

c. t = 5 s.

d. Maximum under Steady State conditions is 110 °C/W.



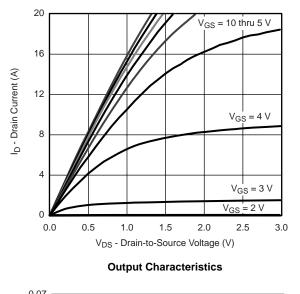
| Parameter | Symbol | Test Conditions | Min. | Тур. | Max. | Unit | |
|---|-------------------------|---|-------|-------|-------|-------|--|
| Static | 1 - | | | | 1 | | |
| Drain-Source Breakdown Voltage | V _{DS} | $V_{GS} = 0 V, I_{D} = -250 \mu A$ | - 30 | | | V | |
| V _{DS} Temperature Coefficient | $\Delta V_{DS}/T_{J}$ | L _ 250 uA | | - 31 | | | |
| V _{GS(th)} Temperature Coefficient | $\Delta V_{GS(th)}/T_J$ | = - 250 µA | | 4.5 | | mV/°C | |
| Gate-Source Threshold Voltage | V _{GS(th)} | $V_{DS} = V_{GS}, I_{D} = -250 \ \mu A$ | - 1.0 | | - 3.0 | V | |
| Gate-Source Leakage | I _{GSS} | $V_{DS} = 0 V, V_{GS} = \pm 20 V$ | | | ± 100 | nA | |
| Zero Gate Voltage Drain Current | I _{DSS} | $V_{DS} = -30 \text{ V}, V_{GS} = 0 \text{ V}$ | | | - 1 | μA | |
| | | V_{DS} = - 30 V, V_{GS} = 0 V, T_{J} = 55 °C | | | - 10 | | |
| On-State Drain Current ^a | I _{D(on)} | $V_{DS} \le$ - 5 V, V_{GS} = - 10 V | - 20 | | | Α | |
| Drain-Source On-State Resistance ^a | | V _{GS} = - 10 V, I _D = - 2.1 A | | 0.032 | | | |
| | R _{DS(on)} | V _{GS} = - 4.5 V, I _D = - 1.0 A | | 0.042 | | Ω | |
| Forward Transconductance ^a | 9 _{fs} | V _{DS} = - 15 V, I _D = - 2.1 A | | 8 | | S | |
| Dynamic ^b | | | | | 1 | | |
| Input Capacitance | C _{iss} | | | 450 | | pF | |
| Output Capacitance | C _{oss} | V _{DS} = - 15 V, V _{GS} = 0 V, f = 1 MHz | | 80 | | | |
| Reverse Transfer Capacitance | C _{rss} | | | 63 | | | |
| Total Gate Charge | _ | $V_{DS} = -15 \text{ V}, \text{ V}_{GS} = -10 \text{ V}, \text{ I}_{D} = -2.1 \text{ A}$ | | 10 | 15 | nC | |
| | Qg | | | 5.1 | 8 | | |
| Gate-Source Charge | Q _{gs} | $V_{\rm DS}$ = - 15 V, $V_{\rm GS}$ = - 4.5 V, $I_{\rm D}$ = - 2.1 A | | 1.8 | | | |
| Gate-Drain Charge | Q _{gd} | | | 2.5 | | | |
| Gate Resistance | R _g | f = 1 MHz | | 7 | | Ω | |
| Turn-On Delay Time | t _{d(on)} | | | 40 | 60 | - ns | |
| Rise Time | t _r | V_{DD} = - 15 V, R_L = 4.6 Ω | | 80 | 120 | | |
| Turn-Off Delay Time | t _{d(off)} | $\rm I_D \cong$ - 3.3 A, $\rm V_{GEN}$ = - 4.5 V, $\rm R_g$ = 1 Ω | | 20 | 30 | | |
| Fall Time | t _f | | | 12 | 20 | | |
| Turn-On Delay Time | t _{d(on)} | | | 5 | 10 | | |
| Rise Time | t _r | V_{DD} = - 15 V, R_L = 4.6 Ω | | 13 | 20 | | |
| Turn-Off Delay Time | t _{d(off)} | $I_D\cong$ - 3.3 A, V_{GEN} = - 10 V, R_g = 1 Ω | | 20 | 30 | | |
| Fall Time | t _f | | | 10 | 15 | | |
| Drain-Source Body Diode Characteristic | cs | | | | | | |
| Continuous Source-Drain Diode Current | ۱ _S | T _C = 25 °C | | | - 2.5 | A | |
| Pulse Diode Forward Current ^a | I _{SM} | | | | - 20 | | |
| Body Diode Voltage | V _{SD} | I _S = - 3.3 A | | - 0.8 | - 1.2 | V | |
| Body Diode Reverse Recovery Time | t _{rr} | | | 20 | 30 | ns | |
| Body Diode Reverse Recovery Charge | Q _{rr} | I _F = - 3.3 A, di/dt = 100 A/μs, T _{.1} = 25 °C | | 20 | 30 | nC | |
| Reverse Recovery Fall Time | t _a | $r_F = -3.5 \text{ A}, \text{ u/ul} = 100 \text{ A/}\mu\text{s}, \text{ I}_J = 25 \text{ °C}$ | | 14 | | | |
| verse Recovery Rise Time t _b | | | | 6 | | ns | |

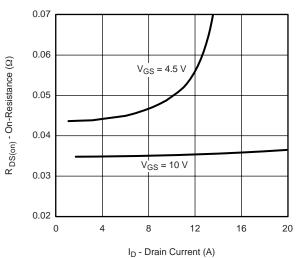
Notes:

a. Pulse test; pulse width \leq 300 $\mu s,$ duty cycle \leq 2 % b. Guaranteed by design, not subject to production testing.

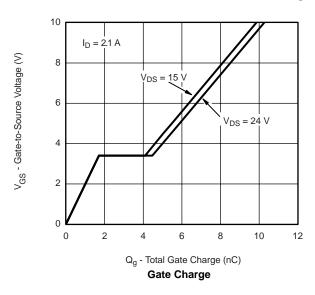
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

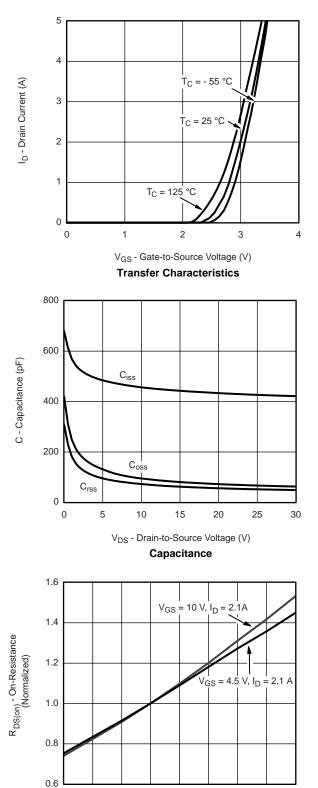






On-Resistance vs. Drain Current and Gate Voltage





 T_J - Junction Temperature (°C) **On-Resistance vs. Junction Temperature**

50

75

100

125 150

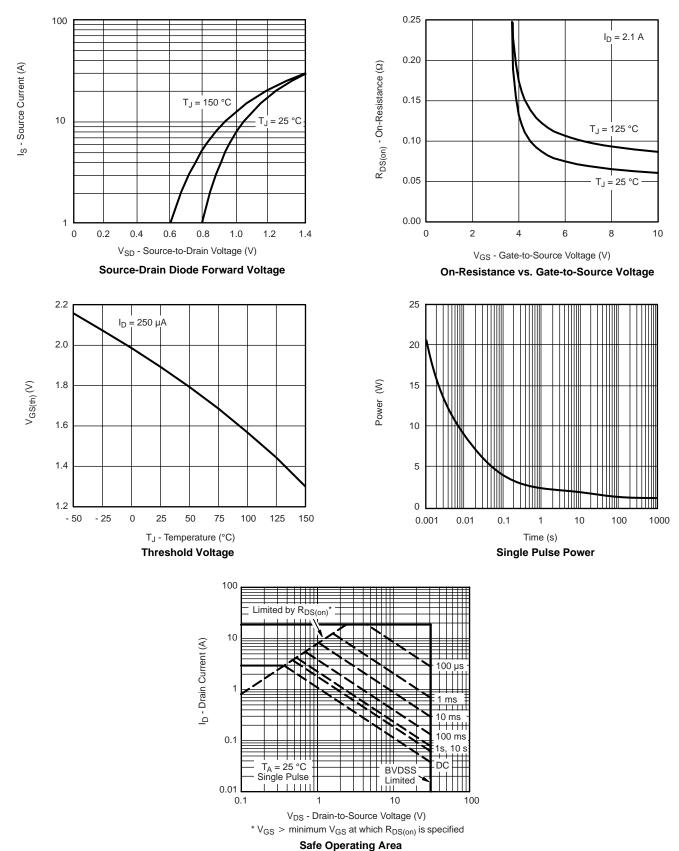
- 50

- 25

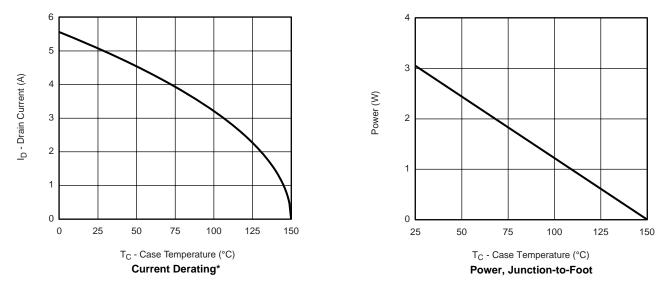
0

25



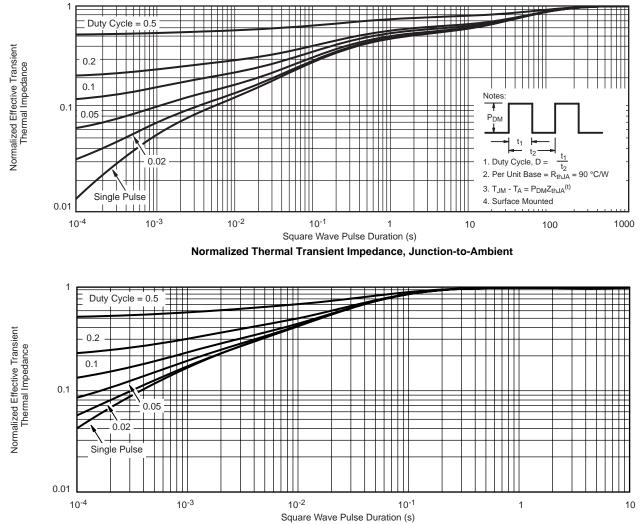






* The power dissipation P_D is based on $T_{J(max)}$ = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





Normalized Thermal Transient Impedance, Junction-to-Foot



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